

**Search Notes**

Application/Control No.

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Examiner

Tse Chen

Applicant(s)/Patent under  
Reexamination

KEDIA ET AL.

Art Unit

2116

**SEARCHED**

Class	Subclass	Date	Examiner

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
text search only - see srch rpt prlvrt	10/28 11/14 11/15/05	TSC